Notice of References Cited Application/Control No. 10/092,815 Examiner Ching Chang Applicant(s)/Patent Under Reexamination FENELON ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

	S.S. I ATEN DOCUMENTO					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-4,592,319	06-1986	Meistrick, Zdenek S.	123/321	
	В	US-4,150,640	04-1979	Egan, John J.	123/321	
	С	US-			=	
	D	US-				
	Ε	US-				
	F	US-				
	G	US-				
	H	US-				
	ı	US-				
	J	US-				
	К	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	:				
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	ט	
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.